Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/024,716	CHO, CHANG-HYUNG	
Examiner	Art Unit	

Examiner

Daquan Zhao

2621

SEARCHED				
Subclass	Date	Examiner		
6-8,27	8/16/2007	DZ		
33,40,95	8/16/2007	DZ		
98	8/16/2007	DZ		
	Subclass 6-8,27 33,40,95 98	Subclass Date 6-8,27 8/16/2007 33,40,95 8/16/2007 98 8/16/2007		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
USPAT; USOCR; USPGPUB; EPO; JPO; DERWENT; IBM_TDB (see search note attached)	8/16/2007	dz	
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